

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/041,005	HALASZ ET AL.	
Examiner		Shin-Hon Chen	Art Unit	Page 1 of 1
		2131		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0174335 A1	11-2002	Zhang et al.	713/168
*	B	US-2002/0157090 A1	10-2002	Anton, Jr., Francis M.	717/178
*	C	US-2002/0090089 A1	07-2002	Branigan et al.	380/270
*	D	US-6,766,453 B1	07-2004	Nessett et al.	713/171
*	E	US-7,073,066 B1	07-2006	Nessett, Danny M.	713/181
*	F	US-7,024,690 B1	04-2006	Young et al.	726/5
*	G	US-2002/0157007 A1	10-2002	Sashihara, Toshiyuki	713/183
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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